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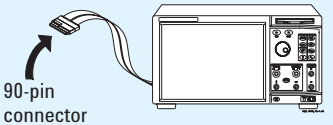
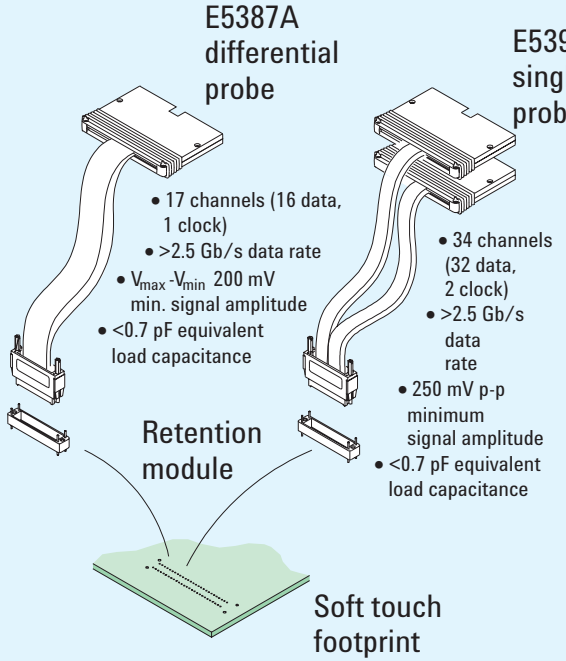
Probing solutions for a logic analyzer module that has a 90-pin cable connector

For information on probe compatibility with a given logic analyzer, go to www.agilent.com/find/logic_analyzer_probes.
For more detailed probing information, see Probing Solutions for Logic Analysis Systems (publication 5968-4632E)



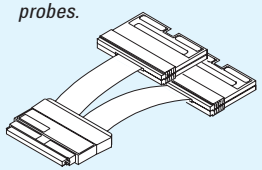
Soft Touch Connectorless Probes

High-density probe with isolation network located at the probe tip. Quick connection to many channels in a small footprint without a connector designed into the target.



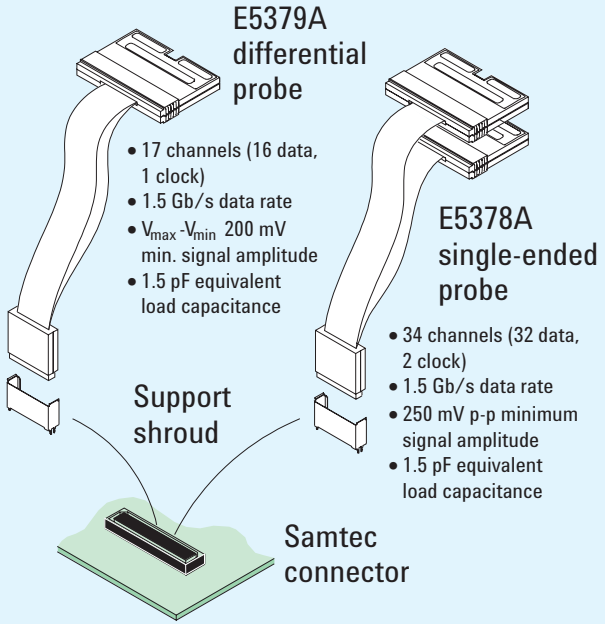
E5386A half-channel adapter

Reduces the number of probes and connectors required to run in half-channel mode (16760A only) when using the soft touch or Samtec probes.



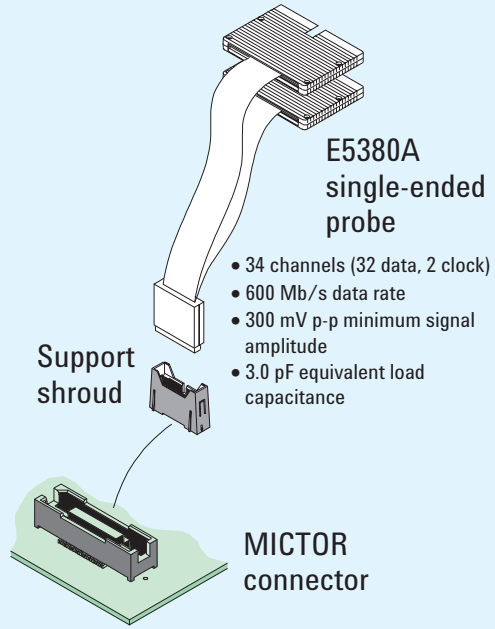
Samtec Probes

High-density probe for 100-pin Samtec connector with isolation network located at the probe tip. Quick connection to many channels in a small footprint. Requires 100-pin Samtec connector designed into target system.



MICTOR Probe

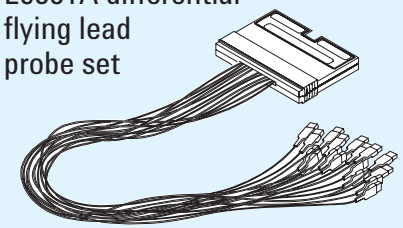
High-density probe for 38-pin MICTOR connector with isolation network located at the probe tip. Quick connection to many channels in a small footprint.



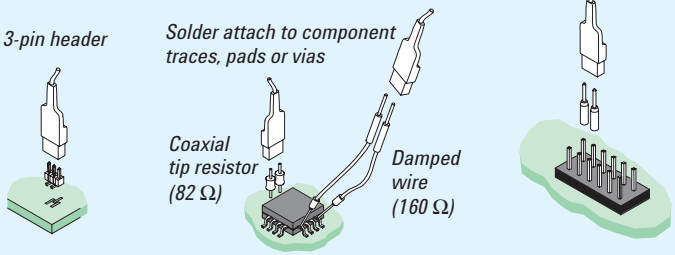
General Purpose Probes and Accessories

General-purpose flying lead set with isolation network located at the probe tip. Flexible connection to individual signals. Compatible with a wide assortment of accessories.

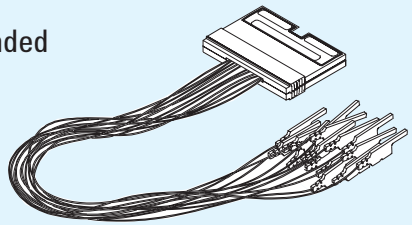
E5381A differential flying lead probe set



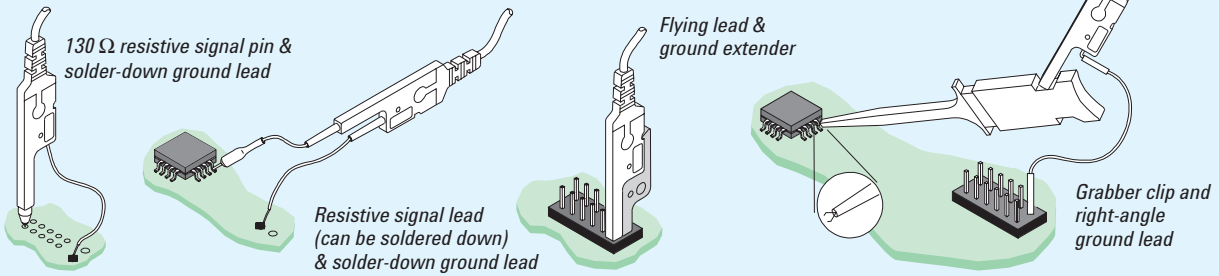
- 17 channels (16 data, 1 clock)
- 1.5 Gb/s data rate
- V_{max} -V_{min} 200 mV min. signal amplitude
- 0.9 pF equivalent load capacitance



E5382A single-ended flying lead probe set



- 17 channels (16 data, 1 clock)
- 1.5 Gb/s data rate
- 250 mV p-p minimum signal amplitude
- 1.3 pF equivalent load capacitance



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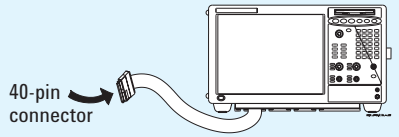
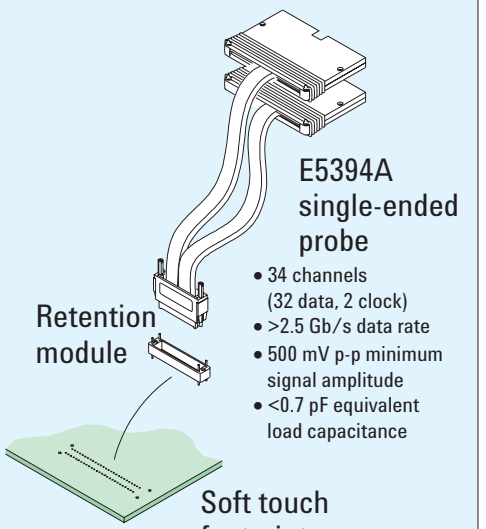
Probing solutions for a module, standalone or PC-hosted logic analyzer that has a 40-pin cable connector.



For information on probe compatibility with a given logic analyzer, go to www.agilent.com/find/logic_analyzer_probes.
For more detailed probing information, see Probing Solutions for Logic Analysis Systems (publication 5968-4632E)

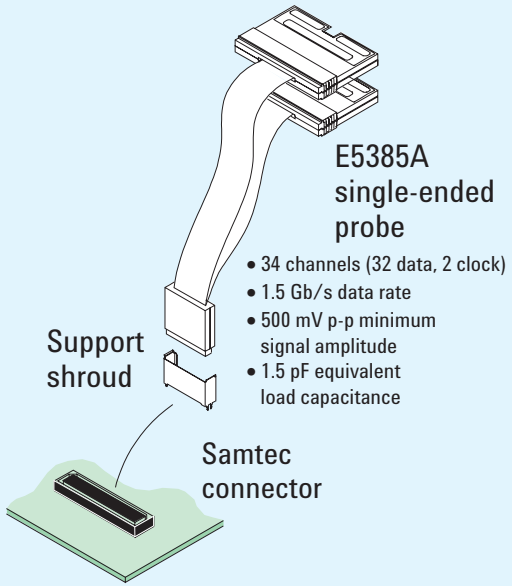
Soft Touch Connectorless Probe

High-density probe with isolation network located at the probe tip. Quick connection to many channels in a small footprint without a connector designed into the target.



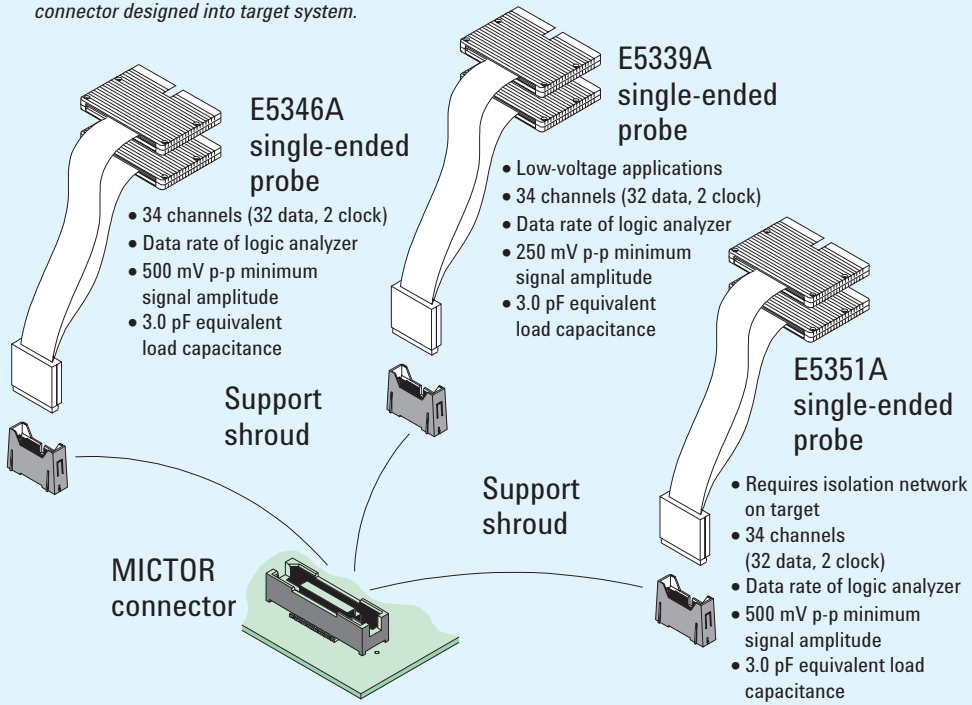
Samtec Probe

High-density probe for 100-pin Samtec connector with isolation network located at the probe tip. Quick connection to many channels in a small footprint. Requires 100-pin Samtec connector designed into target system.



MICTOR Probes

High-density probe for 38-pin MICTOR connector with isolation network located at the probe tip unless noted otherwise. Quick connection to many channels in a small footprint. Requires 38-pin MICTOR connector designed into target system.

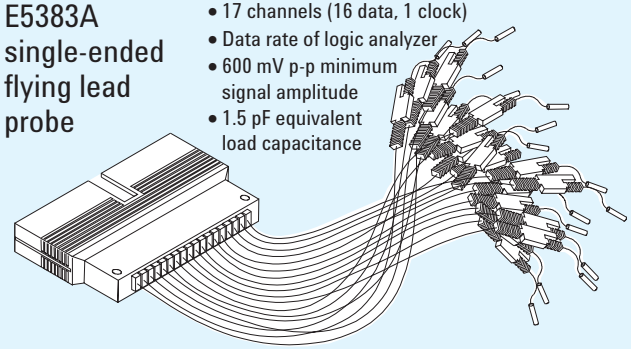


General Purpose Probe and Accessories

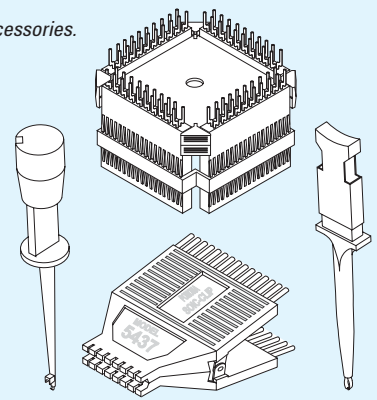
General-purpose flying lead set with isolation network located at the probe tip. Flexible connection to individual signals. Compatible with a wide assortment of accessories.

E5383A single-ended flying lead probe

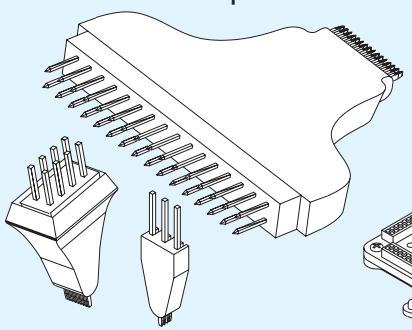
- 17 channels (16 data, 1 clock)
- Data rate of logic analyzer
- 600 mV p-p minimum signal amplitude
- 1.5 pF equivalent load capacitance



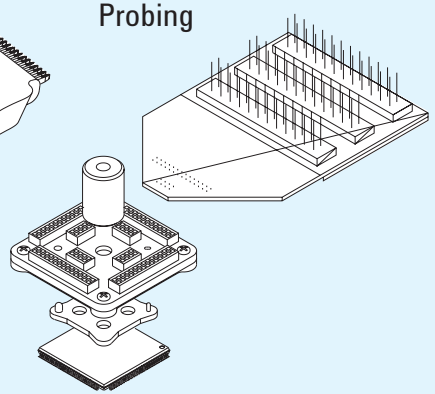
IC Clips



Wedge Adapters



QFP Package Probing



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